


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/690,615	TAKAKURA, HIDEYA	
	Examiner	Art Unit	
	Junghwa M. Im	2811	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search (updated)	2/14/2007	JMI
text search (updated)	2/14/2007	JMI